Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/654,222	SHIRAGAKI ET AL.
Examiner	Art Unit
Hanh Nguyen	2616

	SEARCHED			
Class	Subclass	Date	Examiner	
370	216	4/13/2007	HN	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
370	223	4/13/2007	HN	
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(INCLUDING SEARCH STRATEGY)				
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